

Notice of References Cited	Application/Control No. 10/003,198	Applicant(s)/Patent Under Reexamination ERDFARB, JEFFREY	
	Examiner Amy R Cohen	Art Unit 2859	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6470582	10-2002	Renko, Mark	33/494
	B	US-6467180	10-2002	Chan, Benjamin Hon-Yue	33/512
	C	US-RE37,212	06-2001	Marshall, Forrest A.	33/759
	D	US-5,519,943	05-1996	Snyder, James F.	33/494
	E	US-5,251,382	10-1993	Hellar, James C.	33/759
	F	US-4,811,489	03-1989	Walker, Don W.	33/759
	G	US-4,484,395	11-1984	Samuels, Ricardo	33/494
	H	US-1,602,490	10-1926	Homan, C. A.	33/487
	I	US-1,528,992	03-1925	Rose, M. F.	33/494
	J	US-1,497,492	06-1924	Engel, H. W.	33/494
	K	US-1,085,905	02-1914	Hagey, R. J.	33/494
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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